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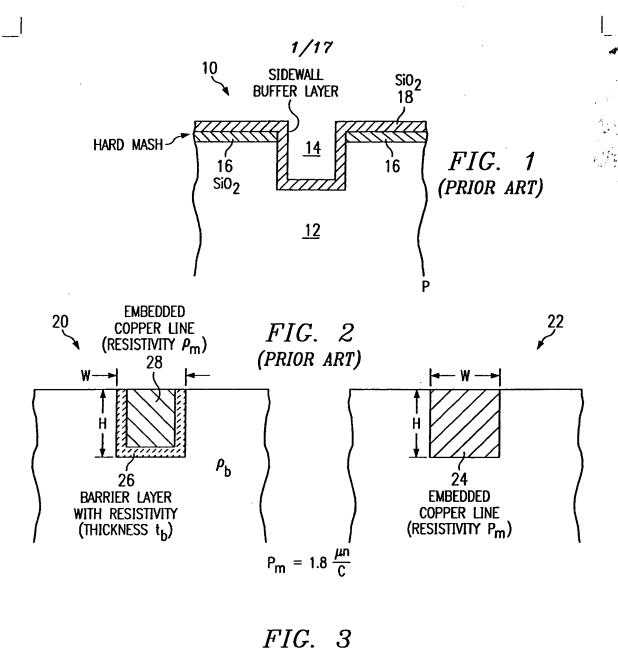
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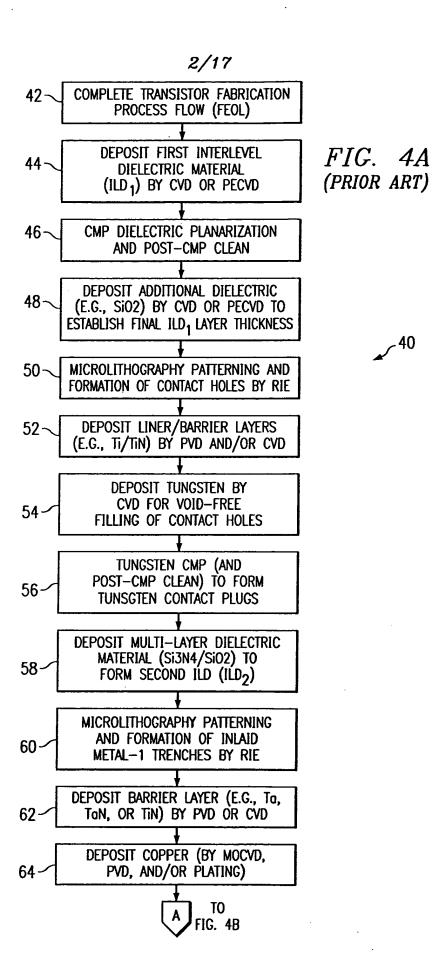
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(PRIOR ART) METAL (N) 34 SILICON NITRIDE METAL (N) SILICON (Sin) Etch NITRIDE 38 36 **STOP** LAYER SILICON **NITRIDE** METAL (N-1) METAL (N-1) SILICON DIOXIDE SILICON DIOXIDE



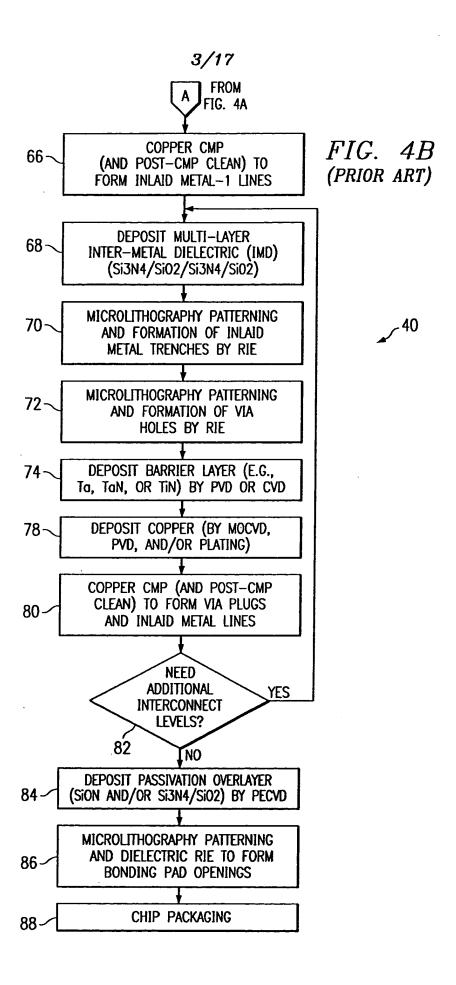
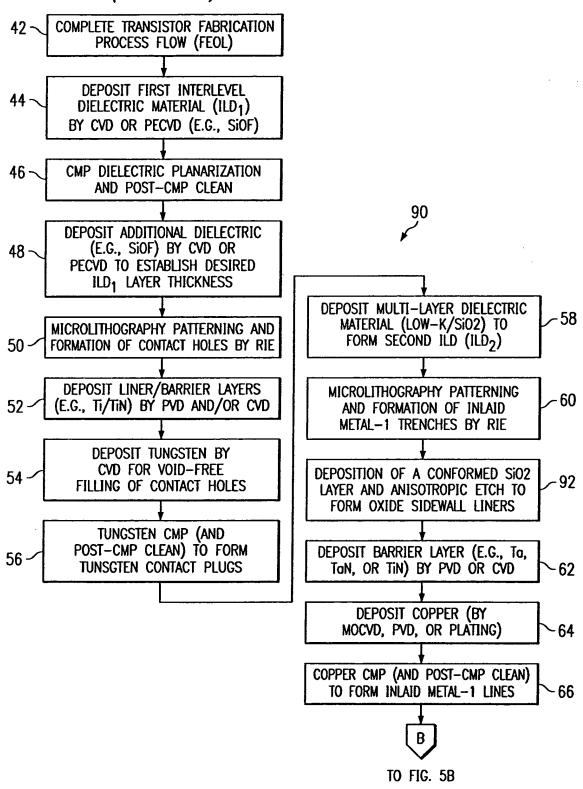
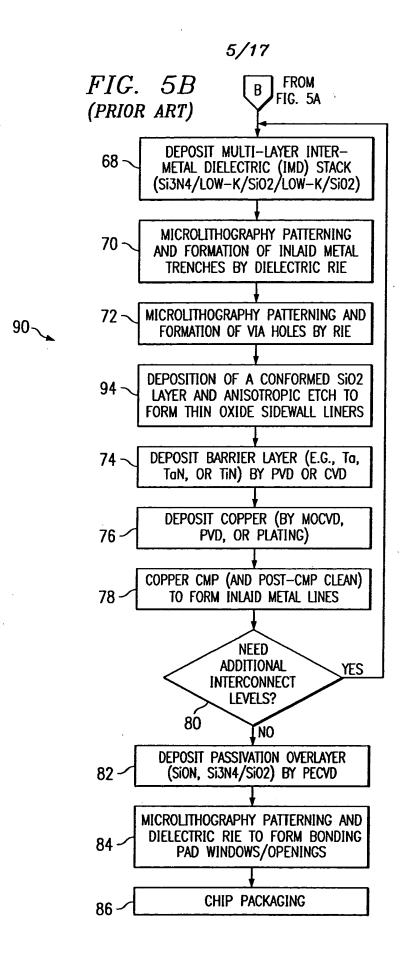
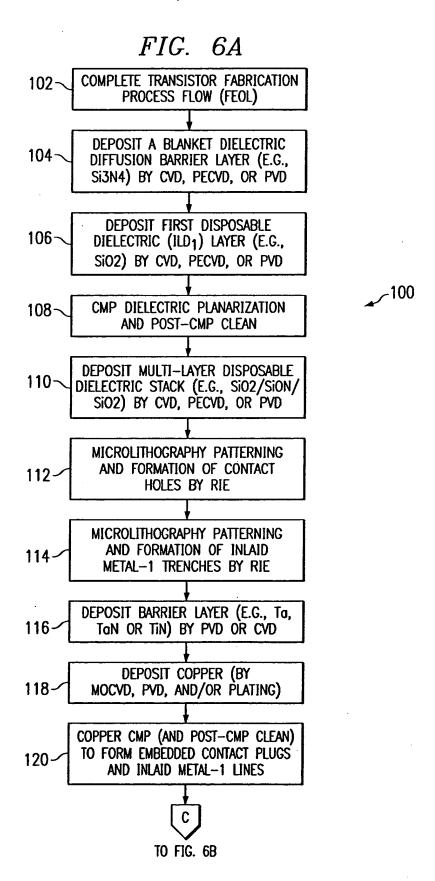
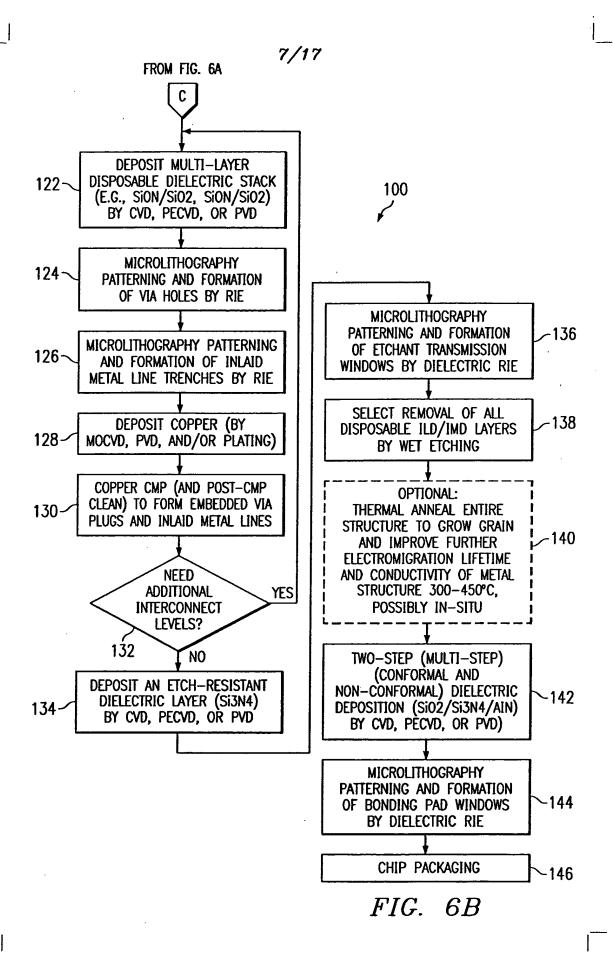


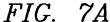
FIG. 5A (PRIOR ART)

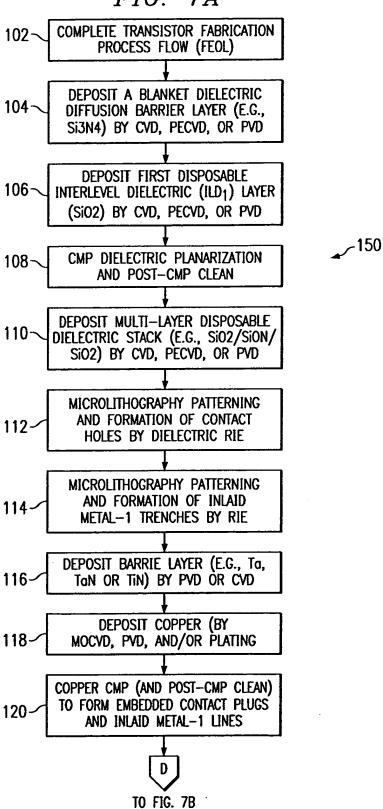


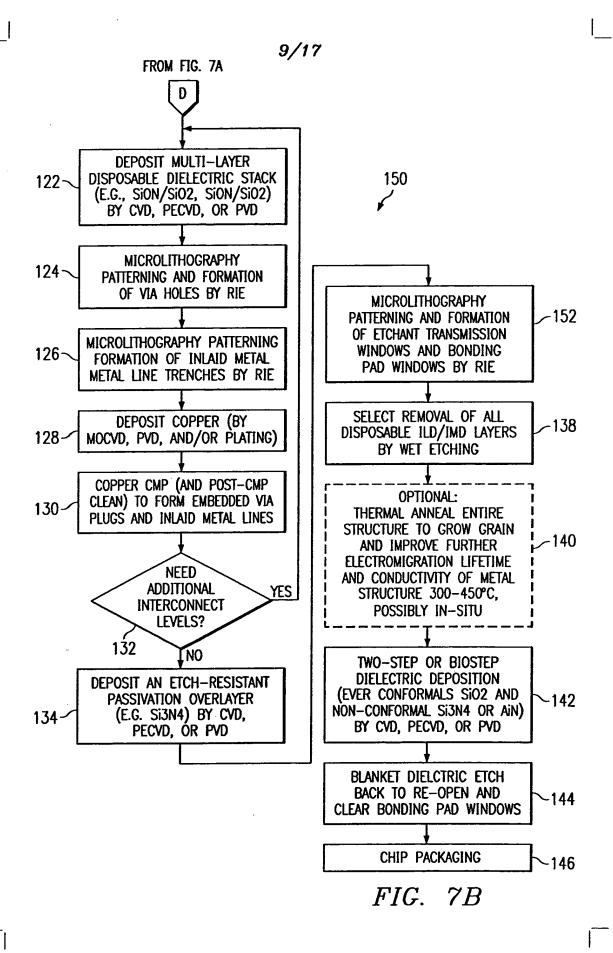












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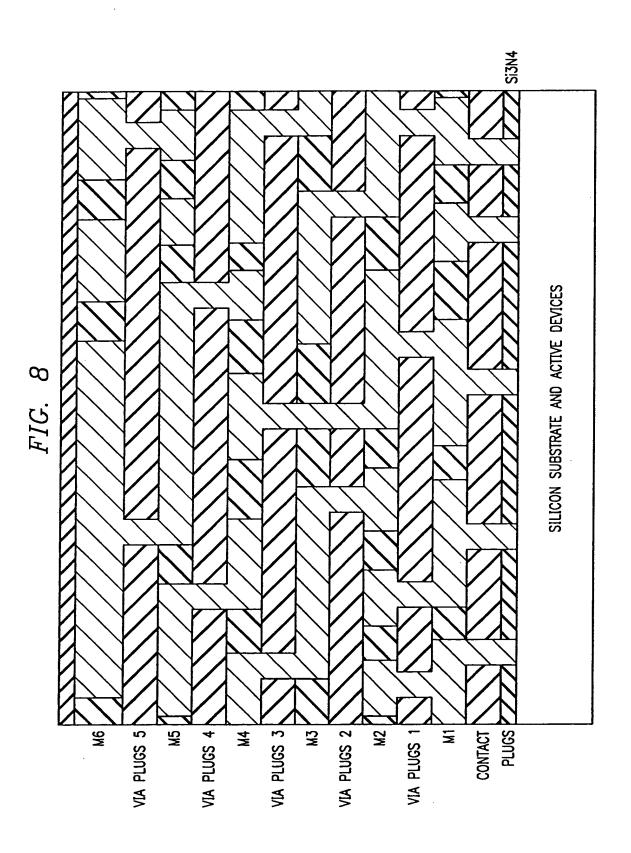


FIG. 9

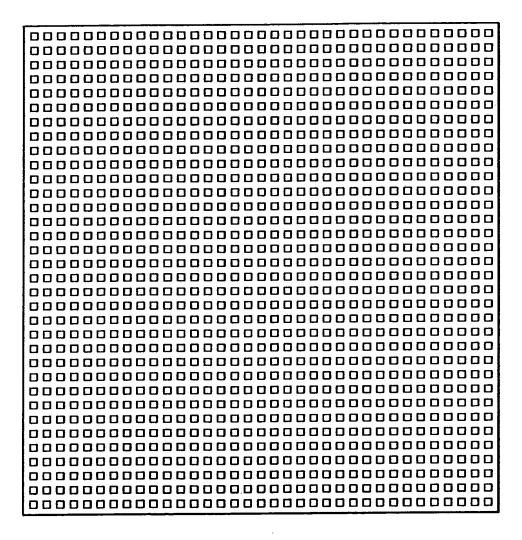


FIG. 10

FIG. 11

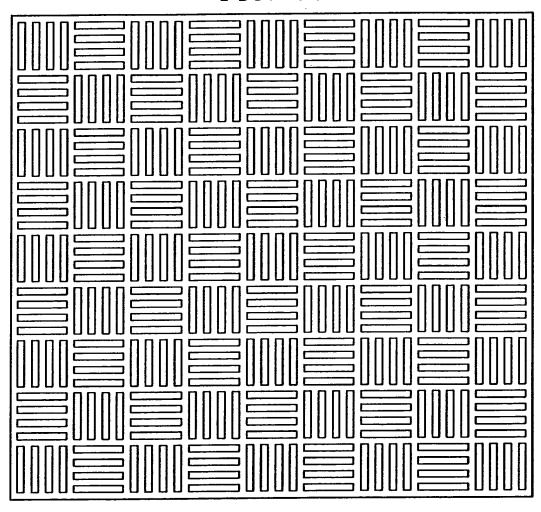
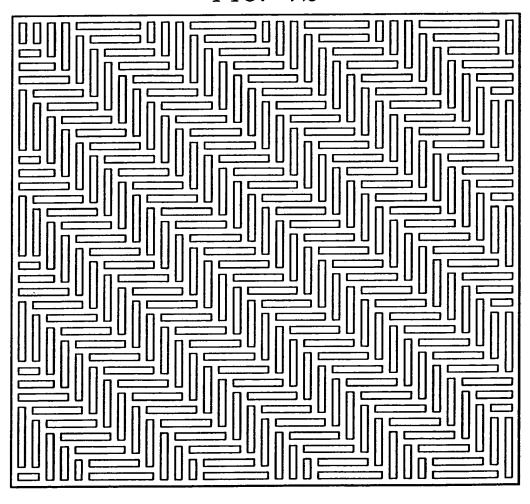
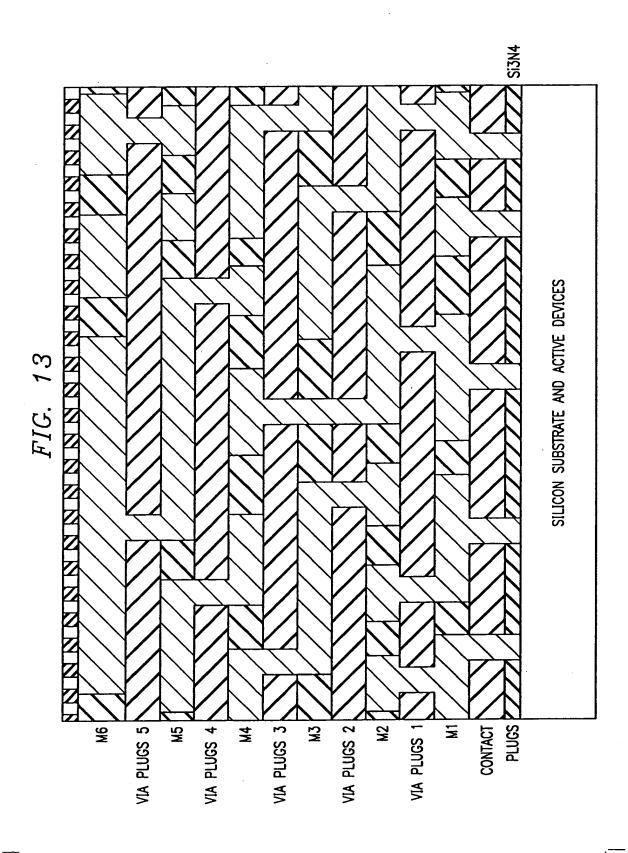
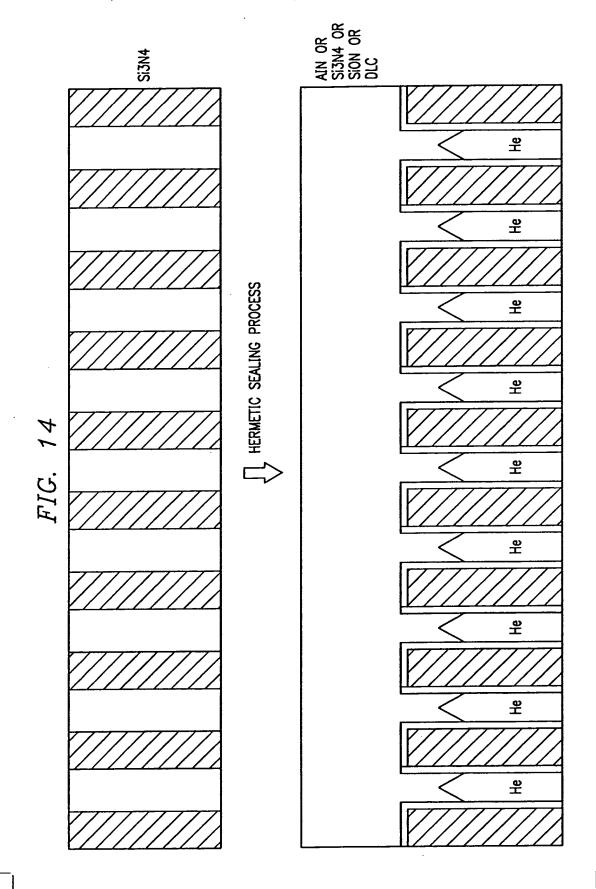


FIG. 12







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